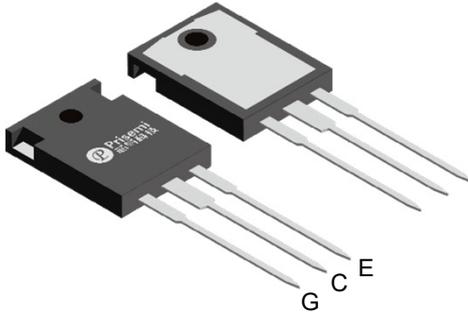
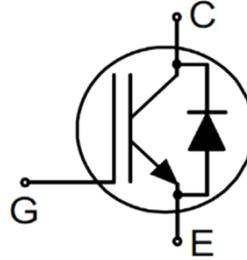
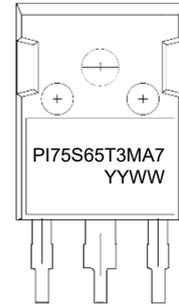


Insulate-Gate Bipolar Transistor
Description

TO-247-3L

Circuit Diagram

Marking (Top View)
Feature

- Ultra-low switching losses
- Benchmark efficiency in hard switching topologies
- Plug-and-play replacement of pure Si-based IGBT
- Internal integrated SiC Schottky Diode (SBD)
- Maximum junction temperature 175°C
- Qualified according to JEDEC
- RoHS compliant

Applications

- Industrial Power Supplies
- Solar String Inverter
- Energy Storage Inverter
- UPS
- DC Charger for Electric Vehicles
- Welding Machines

Absolute maximum rating@25°C

Parameter	Symbol	Value	Units
Collector-Emitter Voltage	V_{CE}	650	V
DC Collector Current (Limited by T_{vjmax})	I_C	$T_C=25^\circ\text{C}$	118
		$T_C=100^\circ\text{C}$	75
Peak Collector Current (t_p Limited by T_{vjmax})	I_{CM}	500	A
Diode Forward Current (Limited by T_{vjmax})@ $T_C=100^\circ\text{C}$	I_F	55	A
Diode Pulse Current (t_p Limited by T_{vjmax})	I_{Fpuls}	210	A
Gate-Emitter Voltage	V_{GE}	± 20	V
Power Dissipation	P_{tot}	$T_C=25^\circ\text{C}$	306
		$T_C=100^\circ\text{C}$	118
Operating Junction Temperature	T_{VJ}	-40~+175	°C
Storage Temperature Range	T_{STG}	-55~+150	°C

Thermal Resistance

Parameter	Symbol	Min.	Typ.	Max.	Unit
IGBT Thermal Resistance (Junction - Case)	$R_{th(J-C)}$	-	0.49	-	K/W
Diode Thermal Resistance (Junction - Case)	$R_{th(J-C)}$	-	0.63	-	K/W
Thermal Resistance (Junction – Ambient)	$R_{th(J-A)}$	-	43	-	K/W

Electrical characteristics per line@25°C (unless otherwise specified)

Parameter	Symbol	Conditions	Min.	Typ.	Max.	Units			
Collector-Emitter Breakdown Voltage	$V_{(BR)CES}$	$V_{GE}=0V, I_C=200\mu A$	650	-	-	V			
Collector-Emitter Saturation Voltage	$V_{CE(sat)}$	$V_{GE}=15V, I_C=75A$	$T_{VJ}=25^\circ C$	-	1.56	2.1	V		
			$T_{VJ}=175^\circ C$	-	1.97	-			
Diode Forward Voltage	V_F	$V_{GE}=0V, I_C=30A$	$T_{VJ}=25^\circ C$	-	1.3	1.6	V		
			$T_{VJ}=175^\circ C$	-	1.56	-			
Gate-Emitter Threshold Voltage	$V_{GE(th)}$	$I_C=0.75mA, V_{CE}=V_{GE}$	3.3	3.8	4.3	V			
Zero Gate Voltage Collector Current	I_{CES}	$V_{CE}=650V, V_{GE}=0V$	$T_{VJ}=25^\circ C$	-	1.0	75	μA		
			$T_{VJ}=175^\circ C$	-	800	-			
Gate-Emitter Leakage Current	I_{GES}	$V_{CE}=0V, V_{GE}=20V$	-	-	100	nA			
Transconductance	g_{fs}	$V_{CE}=20V, I_C=75A$	-	90	-	S			
Gate Charge	Q_G	$I_C=75A, V_{CE}=520V, V_{GE}=15V$	-	191	-	nC			
Input Capacitance	C_{ies}	$V_{CE}=25V, V_{GE}=0V, f=250kHz$	-	5880	-	pF			
Output Capacitance	C_{oes}		-	508	-				
Reverse Transfer Capacitance	C_{res}		-	48	-				
Turn-on Delay Time	$t_{d(on)}$	$I_C=75A, V_{CE}=400V, V_{GE}=0/15V, R_{Gon}=8\Omega, R_{Goff}=8\Omega, \text{Inductive Load}$	$T_{VJ}=25^\circ C$	-	24	-	ns		
			$T_{VJ}=150^\circ C$	-	31	-			
Rise Time	t_r		$T_{VJ}=25^\circ C$	-	32	-			
			$T_{VJ}=150^\circ C$	-	33	-			
Turn-off Delay Time	$t_{d(off)}$		$T_{VJ}=25^\circ C$	-	183	-			
			$T_{VJ}=150^\circ C$	-	194	-			
Fall Time	t_f		$T_{VJ}=25^\circ C$	-	34	-			
			$T_{VJ}=150^\circ C$	-	38	-			
Turn-on Energy	E_{on}		$I_C=75A, V_{CE}=400V, V_{GE}=0/15V, R_{Gon}=8\Omega, R_{Goff}=8\Omega, \text{Inductive Load}$	$T_{VJ}=25^\circ C$	-	1.74		-	mJ
				$T_{VJ}=150^\circ C$	-	2.61		-	
Turn-off Energy	E_{off}	$T_{VJ}=25^\circ C$		-	0.91	-			
		$T_{VJ}=150^\circ C$		-	1.02	-			
Total Switching Energy	E_{ts}	$T_{VJ}=25^\circ C$		-	2.65	-			
		$T_{VJ}=150^\circ C$		-	3.63	-			

Typical Characteristics

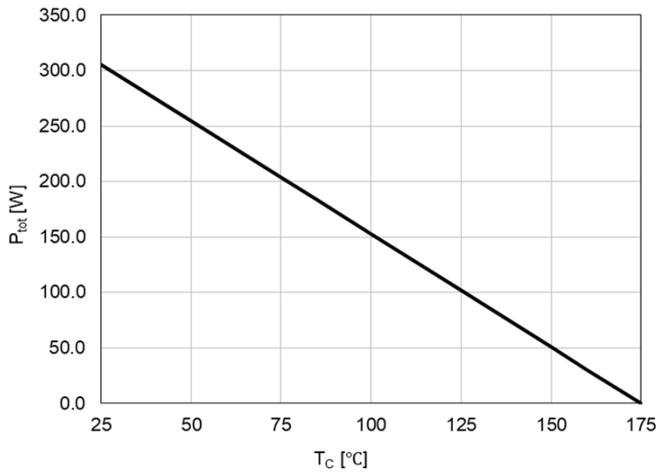


Fig 1. Power dissipation as a function of case temperature ($T_j \leq 175^\circ\text{C}$)

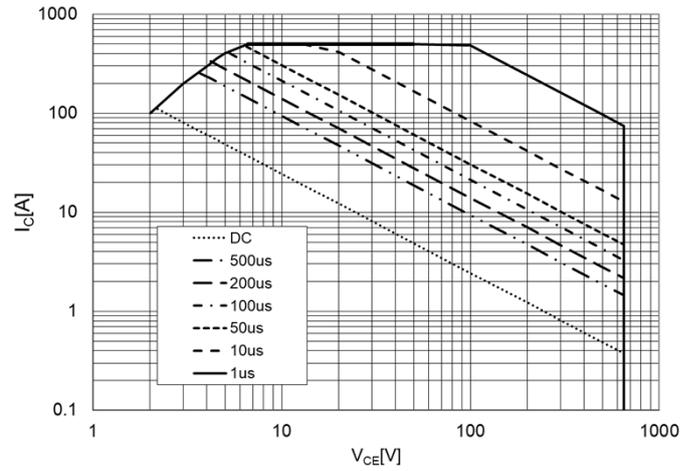


Fig 2. Forward bias safe operating area ($D = 0, T_c = 25^\circ\text{C}, T_j \leq 175^\circ\text{C}, V_{GE} = 15\text{V}$)

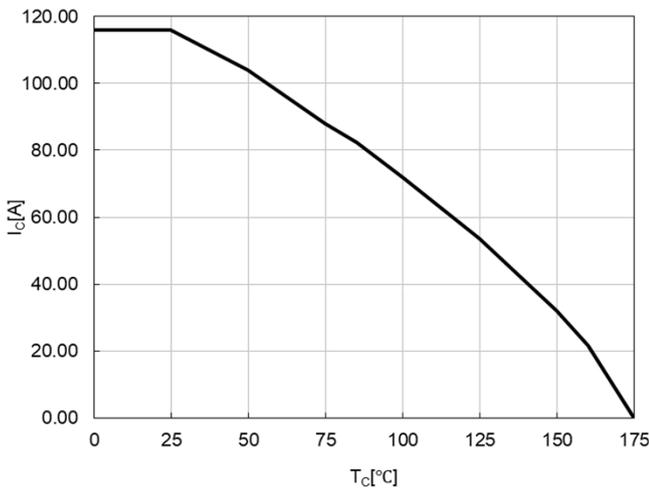


Fig 3. Collector current as a function of case temperature ($V_{GE} \geq 15\text{V}, T_j \leq 175^\circ\text{C}$)

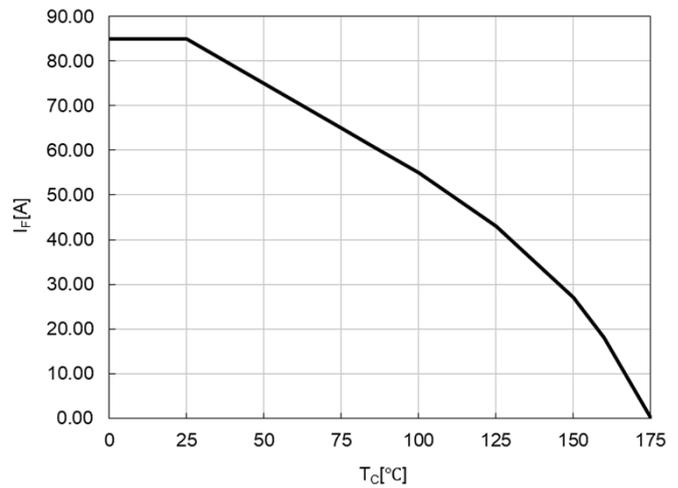


Fig 4. Diode Forward current as a function of case temperature

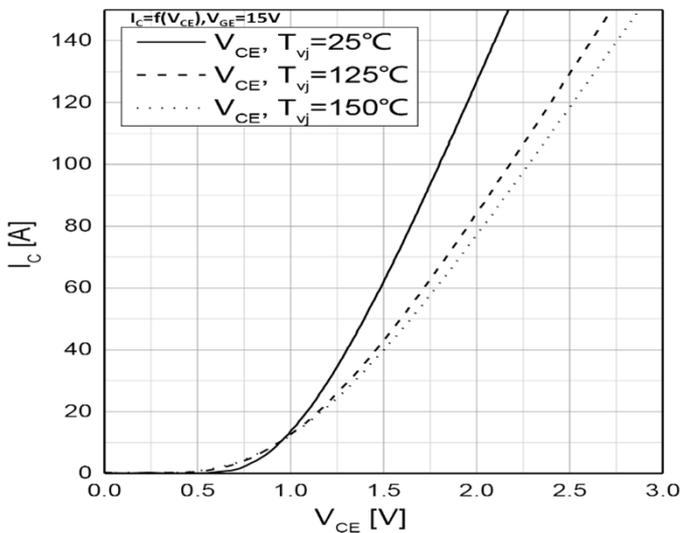


Fig 5. Output Characteristic IGBT(I)

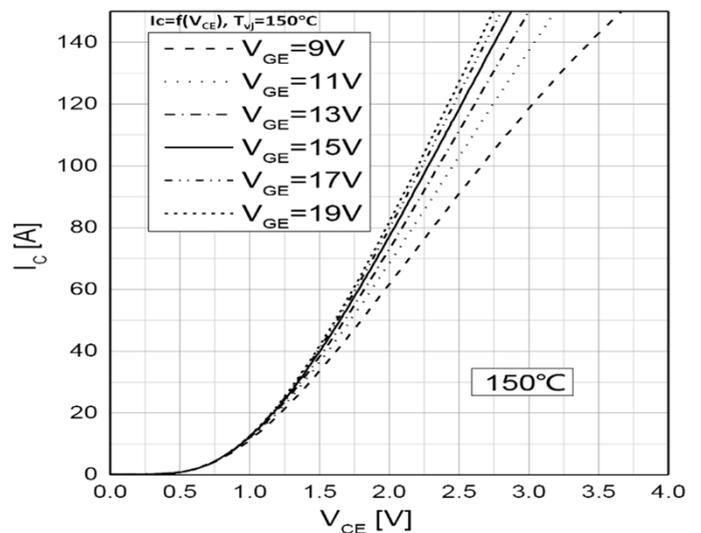


Fig 6. Output Characteristic IGBT(II)

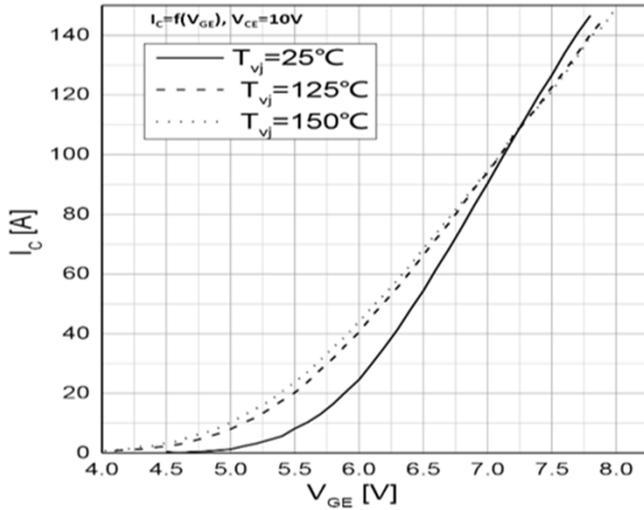


Fig 7. Transfer Characteristic IGBT

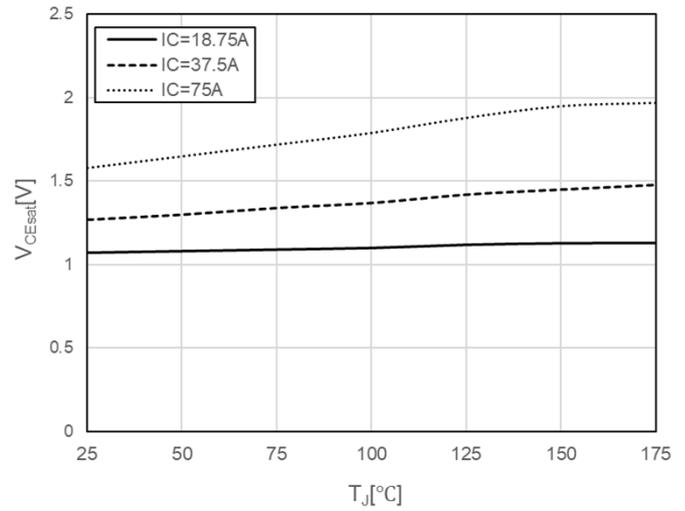


Fig 8. Typical collector-emitter saturation voltage as junction temperature ($V_{GE}=15V$)

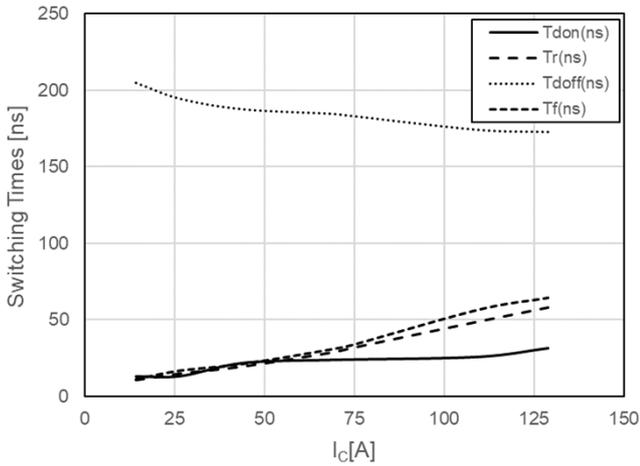


Fig 9. Typical switching times as collector current
($T_J = 25^\circ C$, $V_{CE} = 400V$, $V_{GE} = 15/0V$)

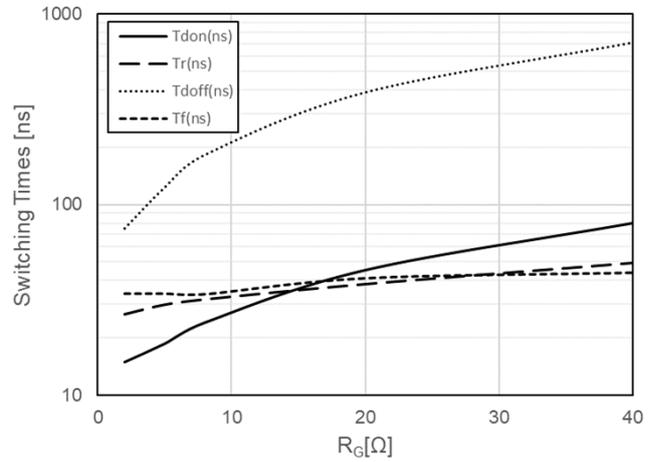


Fig 10. Typical switching times as gate Resistor
($T_J = 25^\circ C$, $V_{CE} = 400V$, $V_{GE} = 15/0V$, $I_C = 75A$)

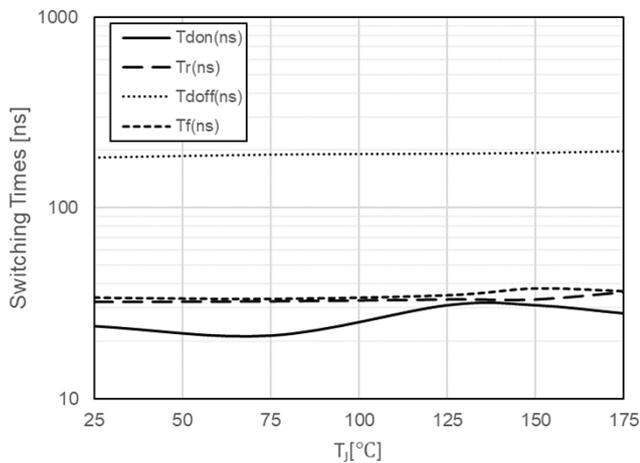


Fig 11. Typical switching times as junction temperature
($V_{CE} = 400V$, $V_{GE} = 15/0V$, $I_C = 75A$)

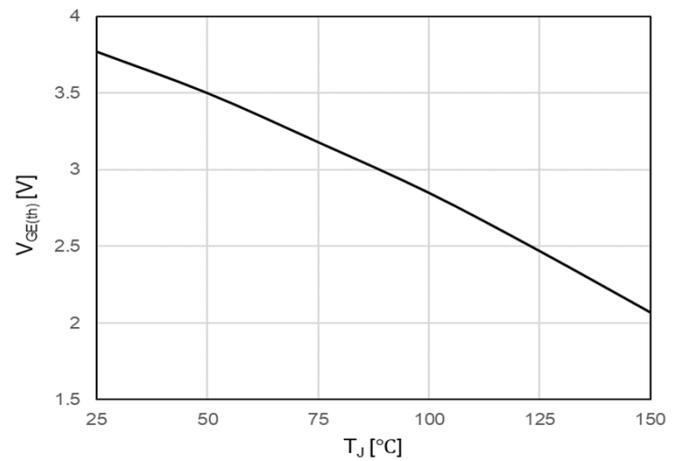


Fig 12. Gate-emitter threshold voltage as junction temperature ($I_C = 0.75mA$)

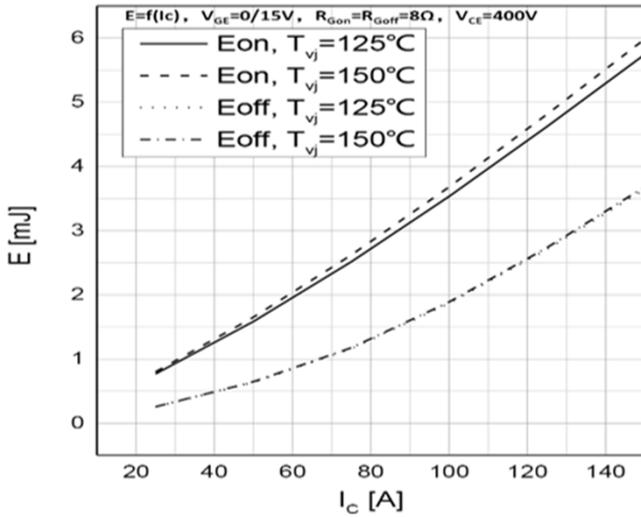


Fig 13. Switching Losses IGBT(I)

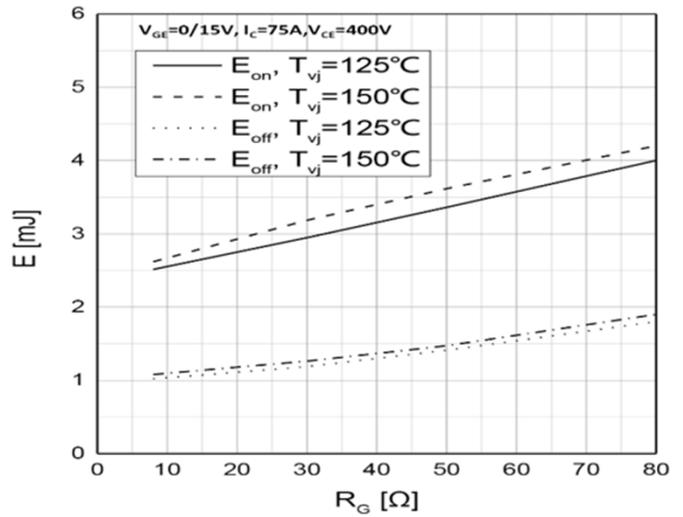


Fig 14. Switching Losses IGBT(II)

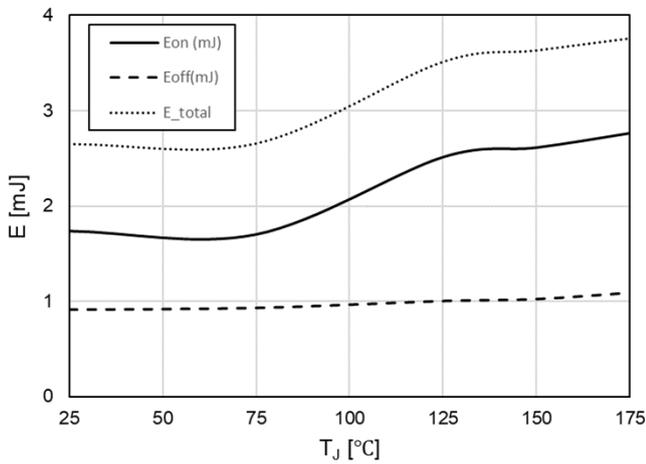


Fig 15. Typical switching energy losses as a function of junction temperature
(Inductive load, V_{CE}= 400V, V_{GE}= 15/0V, I_C = 75A)

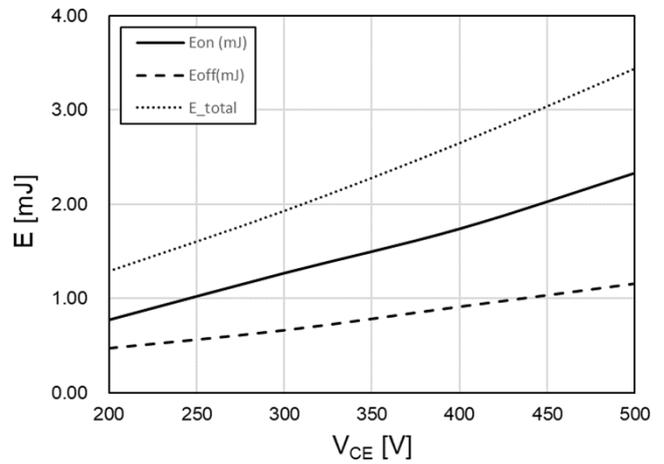


Fig 16. Typical switching energy losses as a function of collector emitter voltage
(Inductive load, T_J= 25°C, V_{GE}= 15/0V, I_C = 75A)

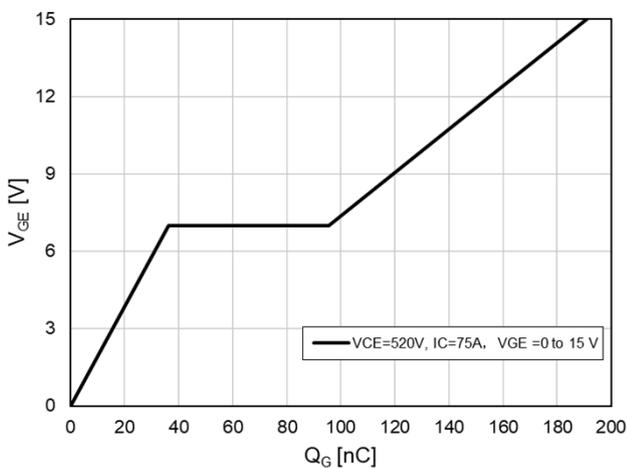


Fig.17. Typical gate charge

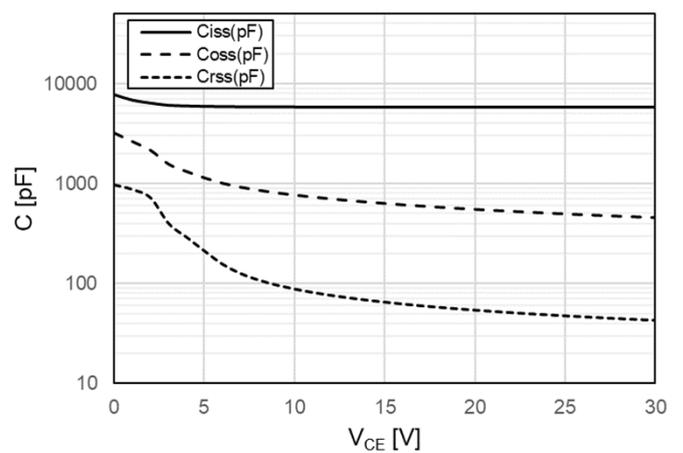


Fig.18. Typical capacitance as a function of collector-emitter voltage
(V_{GE} = 0V, f = 250KHz)

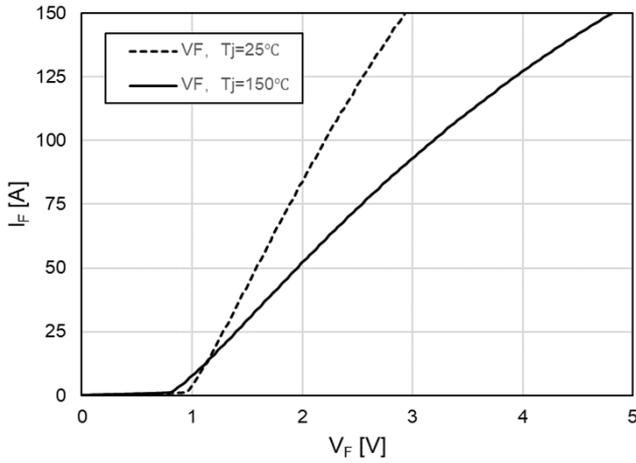


Fig 19. Forward Characteristic Diode

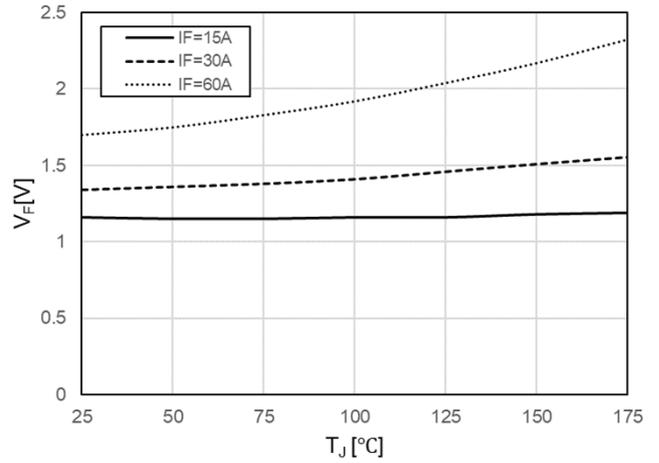


Fig 20. Typical diode forward voltage as a function of junction temperature

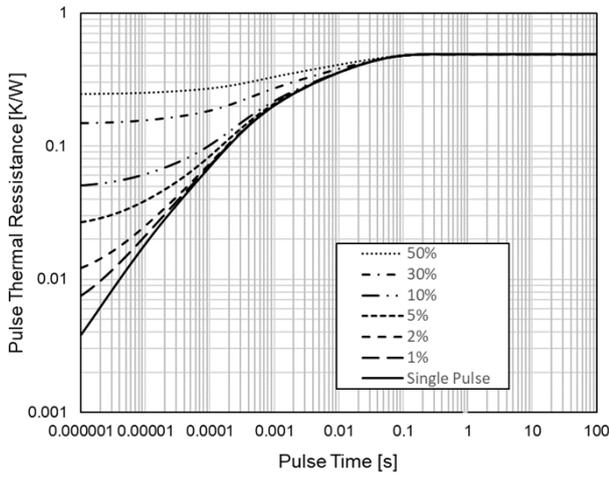


Fig 21. Transient Thermal Impedance IGBT

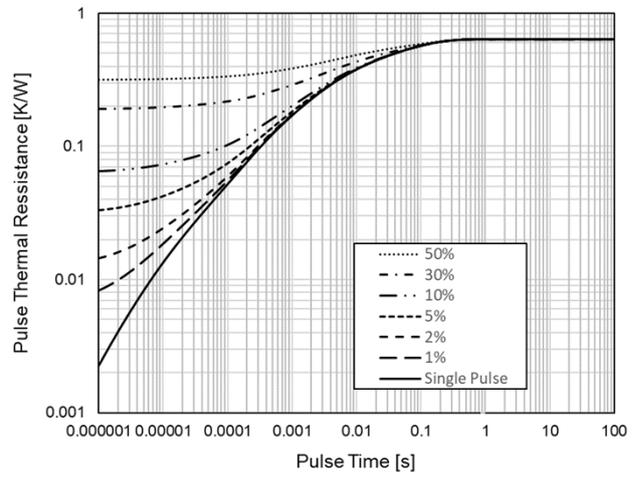
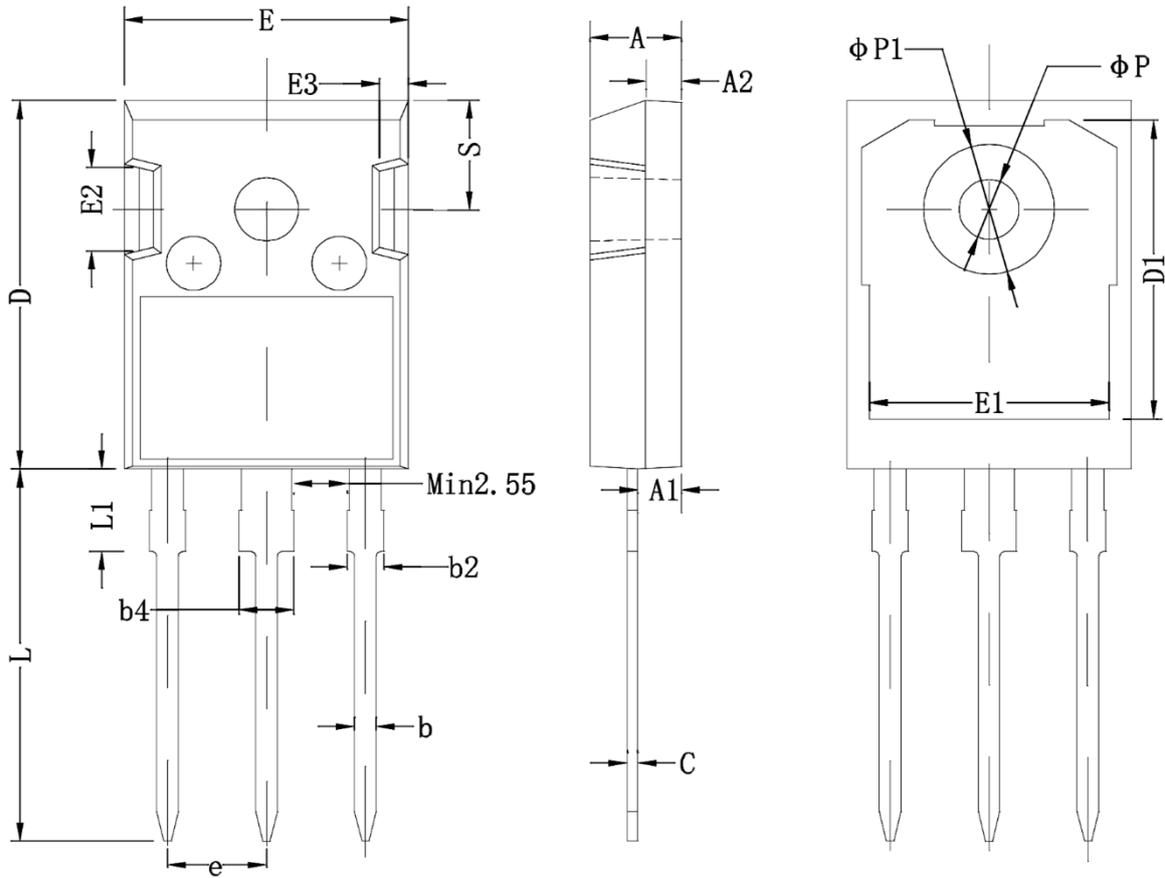


Fig 22. Transient Thermal Impedance Diode

Insulate-Gate Bipolar Transistor

PI75S65T3MA7

Product Dimension (TO-247-3L)



Dim	Millimeters		Inches		Dim	Millimeters		Inches	
	Min	Max	Min	Max		Min	Max	Min	Max
A	4.80	5.20	0.189	0.205	E1	13.00	13.60	0.512	0.535
A1	2.21	2.59	0.087	0.102	E2	4.80	5.20	0.189	0.205
A2	1.85	2.15	0.073	0.085	E3	2.30	2.70	0.091	0.106
b	1.11	1.36	0.044	0.054	e	5.44 BSC.		0.214 BSC.	
b2	1.91	2.21	0.075	0.087	L	19.82	20.22	0.780	0.796
b4	2.91	3.21	0.115	0.126	L1	-	4.30	-	0.169
c	0.51	0.75	0.020	0.030	φP	3.40	3.80	0.134	0.150
D	20.80	21.30	0.819	0.839	φP1	-	7.30	-	0.287
D1	16.25	16.85	0.640	0.663	S	6.15 BSC.		0.242 BSC.	
E	15.50	16.10	0.610	0.634					

IMPORTANT NOTICE

 and **Prisemi**[®] are registered trademarks of **Prisemi Electronics Co., Ltd** (Prisemi), Prisemi reserves the right to make changes without further notice to any products herein. Prisemi makes no warranty, representation or guarantee regarding the suitability of its products for any particular purpose, nor does Prisemi assume any liability arising out of the application or use of any product or circuit, and specifically disclaims any and all liability, including without limitation special, consequential or incidental damages. "Typical" parameters which may be provided in Prisemi data sheets and/or specifications can and do vary in different applications and actual performance may vary over time. All operating parameters, including "Typicals" must be validated for each customer application by customer's technical experts. Prisemi does not convey any license under its patent rights nor the rights of others. The products listed in this document are designed to be used with ordinary electronic equipment or devices, Should you intend to use these products with equipment or devices which require an extremely high level of reliability and the malfunction of which would directly endanger human life (such as medical instruments, aerospace machinery, nuclear-reactor controllers, fuel controllers and other safety devices), please be sure to consult with our sales representative in advance.

Website: <http://www.prisemi.com>

For additional information, please contact your local Sales Representative.

©Copyright 2009, Prisemi Electronics

 **Prisemi**[®] is a registered trademark of Prisemi Electronics.

All rights are reserved.